

CLAIM LISTING

This listing of claims will replace all prior versions, and listings of claims in the application:

AMENDMENTS TO THE CLAIMS

1. (Previously Presented) A package lid for attaching to a package substrate of a packaged semiconductor comprising:
a sloped wall configured to provide an exposed perimeter portion of the package substrate when the package lid is disposed on the package substrate to allow application of a molding compound on the exposed perimeter portion of the package substrate, the molding compound contacting only an exterior surface of the sloped wall so as to secure the package lid to the package substrate of the packaged semiconductor.
2. (Original) The package lid of claim 1 wherein the sloped wall has a slope angle between 30 degrees and 60 degrees.
3. (Original) The package lid of claim 1 further comprising a foot around at least a portion of the perimeter of the sloped wall, configured to contact the package substrate when the package lid is placed on the package substrate.
4. (Original) The package lid of claim 1 wherein the package lid is a stamped package lid.
5. (Original) The package lid of claim 4 wherein the stamped package lid has a thickness less than 2.39 mm.
6. (Original) The package lid of claim 4 wherein the stamped package lid has a thickness of about 0.79 mm.
7. (Original) The package lid of claim 4 wherein the stamped package lid has a thickness between about 0.45 mm and about 2.39 mm.

8. (Original) The package lid of claim 6 wherein the stamped package lid comprises nickel-plated copper.
9. (Previously Presented) The package lid of claim 1 further comprising a vent allowing gases to escape during assembly of the packaged semiconductor to a printed circuit assembly.
10. (Original) The package lid of claim 9 wherein the vent is provided in a side of the package lid.
11. (Original) The package lid of claim 10 wherein the vent comprises a gap in the sloped wall.
12. (Original) The package lid of claim 1 further comprising a rim forming a vertical wall around a top of the package lid.
13. (Original) The package lid of claim 12 further comprising fiducial marks formed in the rim.
14. (Original) The package lid of claim 13 wherein fiducial marks are formed in corners of a rectangular package lid.
15. (Original) The package lid of claim 1 wherein the package lid is substantially rectangular.
16. (Original) The package lid of claim 15 wherein the lid covers a rectangular semiconductor integrated circuit a side at least 25.4 mm long.
17. (Original) The package lid of claim 4 wherein the stamped package lid is rectangular and covers a programmable logic device at least 25.4 mm long on a first side.

18. (Original) The package lid of claim 1 wherein the exposed perimeter portion of the package substrate comprises polymer material.

19. (Original) The package lid of claim 1 wherein the package lid is disposed on the package substrate to provide the exposed perimeter portion and further comprising:

first molding compound applied to a first portion of the exposed perimeter portion and contacting the sloped sidewall, and

second molding compound applied to a second portion of the exposed perimeter portion and contacting the sloped sidewall, wherein the first portion of the exposed perimeter portion is opposite the second portion of the exposed perimeter portion.

20. (Original) The package lid of claim 19 wherein the package substrate includes an organic resin.

21. (Original) The package lid of claim 19 wherein the package substrate includes a solder ball-grid array for connecting the packaged semiconductor to a printed circuit assembly.

22. (Withdrawn) A method of packaging a semiconductor integrated circuit comprising:

attaching the semiconductor integrated circuit to a package substrate;

placing a package lid having a sloped wall on the package substrate over the semiconductor IC to leave an exposed perimeter portion of the package substrate;

applying molding compound to the exposed perimeter portion of the package substrate and the sloped wall;

hardening the molding compound to attach the package lid to the package substrate to provide a packaged integrated circuit.

23. (Withdrawn) The method of claim 22 wherein the step of attaching the semiconductor integrated circuit to the package substrate comprises a first solder re-flow process of a first ball-grid array.

24. (Withdrawn) The method of claim 22 further comprising a step, after the step of hardening the molding compound to attach the package lid to the package substrate, of attaching the packaged integrated circuit to a printed circuit board using a second solder re-flow process of a second ball-grid array.

25. (Withdrawn) The method of claim 22 wherein the molding compound is applied in a plastic or fluid state.

26. (Withdrawn) The method of claim 22 further comprising a step, prior to the step of placing the package lid having the sloped wall on the package substrate over the semiconductor IC, of stamping the package lid out of metal.

27. (Withdrawn) The method of claim 26 wherein the metal comprises nickel-plated copper.

28. (Withdrawn) The method of claim 26 wherein the metal is less than 0.79 mm thick.

29. (Withdrawn) The method of claim 26 wherein the metal is about 0.79 mm thick.

30. (Withdrawn) The method of claim 22 wherein the exposed perimeter portion is about 1 mm wide.

31. (Currently Amended) A packaged semiconductor comprising:
means for providing a sloped wall of the package lid;
means for providing an exposed perimeter portion of the package substrate;
~~and~~
means for securing the package lid to the package substrate by applying molding compound to ~~only~~ external portions of the sloped wall of the package lid and the exposed perimeter portion of the package substrate so as to leave a space within the packaged semiconductor not filled with molding compound; and
means for venting gases from the space when the packaged semiconductor is soldered to a printed circuit board.
32. (Currently Amended) A packaged semiconductor comprising:
a package substrate having an exposed perimeter portion;
a semiconductor integrated circuit mechanically and electrically attached to the package substrate with a ball grid array attachment;
a metal package lid having a sloped wall, a top, and a vent allowing gases to escape during assembly of the packaged semiconductor to a printed circuit assembly;
molding compound applied to ~~only~~ external portions of the exposed perimeter portion of the package substrate and external portions of the sloped wall of the metal package lid so as to secure the package lid to the package substrate; and
thermal grease disposed between the semiconductor integrated circuit and the top of the metal package lid.